Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination
10/038,655	ITO, HIDETAKA
Examiner	Art Unit
Dustin Nguyen	2154

SEARCHED				
Class	Subclass	Date	Examiner	
370	217	4/19/2006	DN	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	<u> </u>			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
double patenting search	4/19/2006	DN	
<u> </u>			